

CMPA2735075D

75 W, 2.7 - 3.5 GHz, GaN MMIC, Power Amplifier

Description

The CMPA2735075D is a gallium nitride (GaN) high electron mobility transistor (HEMT) based monolithic microwave integrated circuit (MMIC). GaN has superior properties compared to silicon or gallium arsenide, including higher breakdown voltage, higher saturated electron drift velocity, and higher thermal conductivity. GaN HEMTs also offer greater power density and wider bandwidths compared to Si and GaAs transistors. This MMIC contains a two-stage reactively matched amplifier design approach enabling very wide bandwidths to be achieved.

Features

- 30 dB small signal gain
- 80 W typical P_{SAT}
- Operation up to 28 V
- High breakdown voltage
- High temperature operation
- Size 0.197 x 0.174 x 0.004 inches

Applications

- Civil and military pulsed radar amplifiers

Typical Performance Over 2.7 - 3.5 GHz ($T_c = 25\text{ }^\circ\text{C}$)

Parameter	2.7 GHz	2.9 GHz	3.1 GHz	3.3 GHz	3.5 GHz	Units
Small Signal Gain	29	30	31	30	30	dB
Saturated Output Power	63	80	93	93	86	W
PAE @ P_{SAT}	46	57	60	62	63	%

Note:

P_{SAT} is defined as the RF output power where the device starts to draw positive gate current in the range of 2-8 mA.



Absolute Maximum Ratings (Not Simultaneous) at 25 °C

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	84	V_{DC}
Gate-to-Source Voltage	V_{GS}	-10, +2	V_{DC}
Storage Temperature	T_{STG}	-65, +150	°C
Operating Junction Temperature	T_J	225	°C
Thermal Resistance, Junction to Case (Packaged) ¹	$R_{\theta JC}$	1.8	°C/W
Mounting Temperature (30 Seconds)	T_S	320	°C

Note:

¹ Eutectic die attach using 80/20 AuSn solder mounted to a 40 mil thick CuW carrier.

Electrical Characteristics (Frequency = 2.7 GHz to 3.5 GHz Unless Otherwise Stated; $T_c = 25\text{ °C}$)

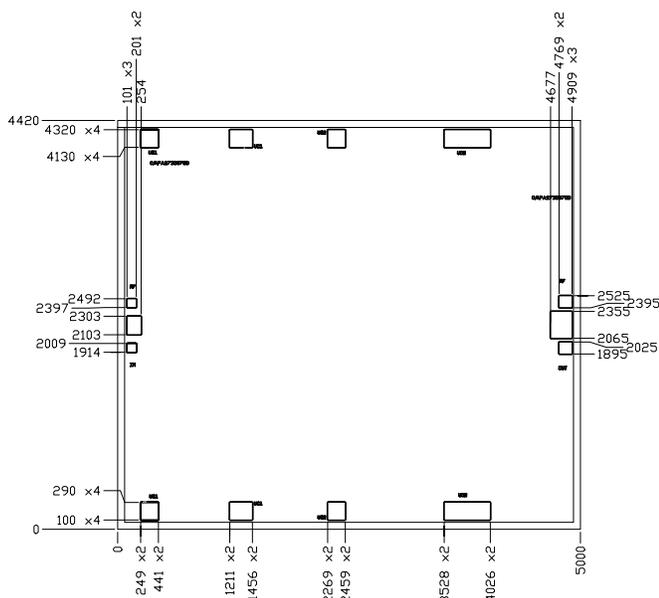
Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
DC Characteristics						
Gate Threshold Voltage	$V_{GS(TH)}$	-3.8	-3.0	-2.3	V	$V_{DS} = 10\text{ V}, I_D = 28\text{ mA}$
Gate Quiescent Voltage	$V_{GS(Q)}$	-	-2.7	-	V	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}$
Saturated Drain Current	I_{DS}	19.6	27.4	-	A	$V_{DS} = 6.0\text{ V}, V_{GS} = 2.0\text{ V}$
Drain-Source Breakdown Voltage	V_{BD}	84	100	-	V	$V_{GS} = -8\text{ V}, I_D = 28\text{ mA}$
RF Characteristics²						
Small Signal Gain ¹	S21	27.4	30	-	dB	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 2.7 - 3.5\text{ GHz}$
Input Return Loss	S11	-	-15	-6.5	dB	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 2.7 - 3.5\text{ GHz}$
Output Return Loss	S22	-	-11	-4	dB	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 2.7 - 3.5\text{ GHz}$
Output Power	P_{OUT}	48	66	-	W	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 2.7\text{ GHz}, P_{IN} = 27\text{ dBm}$
Output Power	P_{OUT}	74	97	-	W	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 3.1\text{ GHz}, P_{IN} = 27\text{ dBm}$
Output Power	P_{OUT}	76	91	-	W	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 3.5\text{ GHz}, P_{IN} = 27\text{ dBm}$
Power Added Efficiency	PAE	35	48	-	%	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 2.7\text{ GHz}, P_{IN} = 27\text{ dBm}$
Power Added Efficiency	PAE	52	61	-	%	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 3.1\text{ GHz}, P_{IN} = 27\text{ dBm}$
Power Added Efficiency	PAE	55	63	-	%	$V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, \text{Freq} = 3.5\text{ GHz}, P_{IN} = 27\text{ dBm}$
Output Mismatch Stress	VSWR	-	-	5:1	Y	No Damage at All Phase Angles, $V_{DD} = 28\text{ V}, I_{DQ} = 800\text{ mA}, P_{OUT} = 75\text{ W}$

Notes:

¹ Scaled from PCM data.

² All data pulse tested on-wafer with pulse width = 10 μs , duty cycle = 1%.

Die Dimensions (Units in Microns)



Overall Die Size 5000 x 4420 (+0/-50) Microns, Die Thickness 100 (+/-10) Microns.
All Gate and Drain Pads Must be Wire Bonded for Electrical Connection.

Pad Number	Function	Description	Pad Size (Microns)	Note
1	RF_IN	RF-Input Pad. Matched to 50 ohm	200 x 153	3
2	VG1_A	A Gate Control for Stage 1. $V_G \sim 2.0 - 3.5 V$	190 x 192	1, 2
3	VG1_B	Gate Control for Stage 1. $V_G \sim 2.0 - 3.5 V$	190 x 192	1, 2
4	VD1_A	Drain Supply for Stage 1. $V_D = 28 V$	190 x 245	1
5	VD1_B	Drain Supply for Stage 1. $V_D = 28 V$	190 x 245	1
6	VG2_A	Gate Control for Stage 2A. $V_G \sim 2.0 - 3.5 V$	190 x 190	1
7	VG2_B	Gate Control for Stage 2B. $V_G \sim 2.0 - 3.5 V$	190 x 190	1
8	VD2_A	Drain Supply for Stage 2A. $V_D = 28 V$	190 x 498	1
9	VD2_B	Drain Supply for Stage 2B. $V_D = 28 V$	190 x 498	1
10	RF_Out	RF-Output Pad. Matched to 50 ohm	290 x 232	3

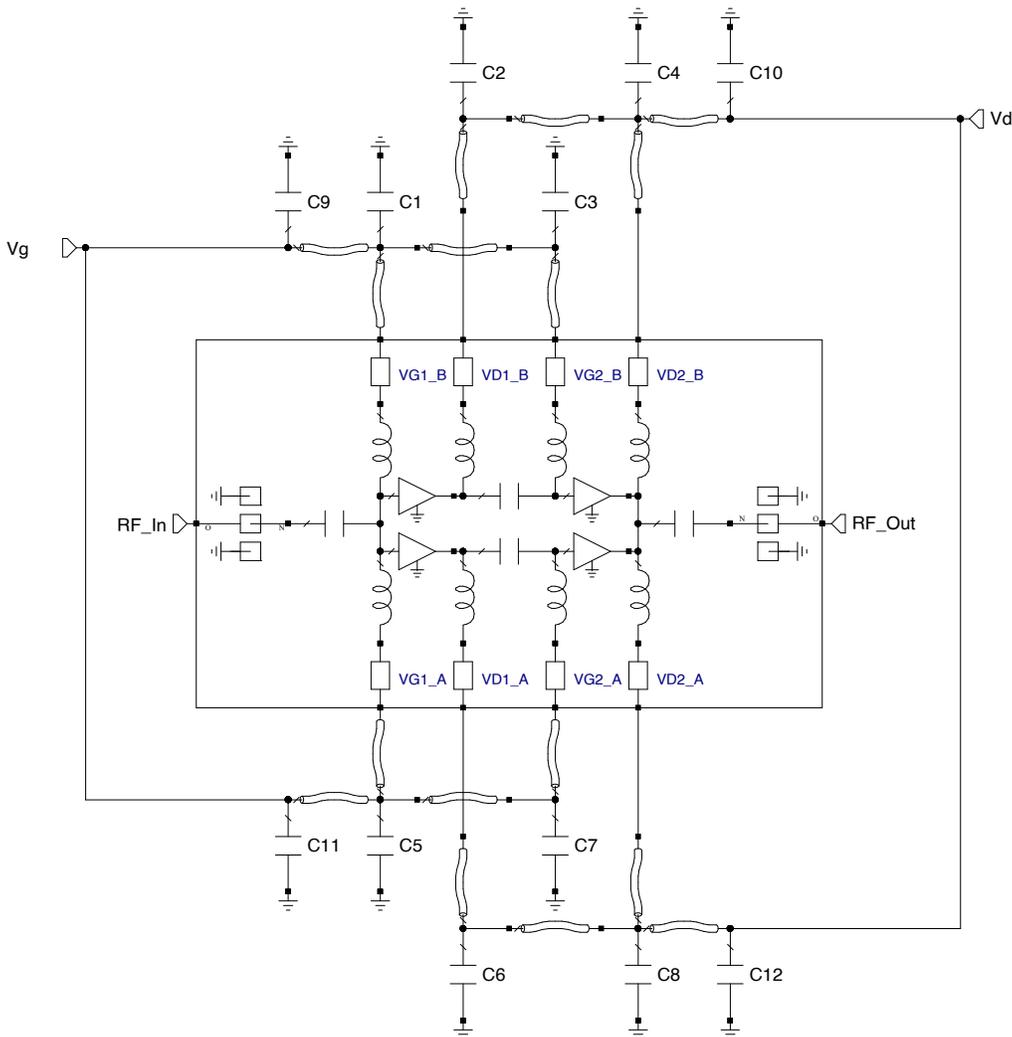
Notes:

- ¹ Attach bypass capacitors to pads 2-9 per application circuit.
- ² VG1_A and VG1_B are connected internally so it would be enough to connect either one for proper operation.
- ³ The RF input and output pad have a ground-signal-ground with a nominal pitch of 10 mil (250 um). The RF ground pads are 100 x 100.

Assembly Notes:

- Recommended solder is AuSn (80/20) solder. Refer to the website for the Eutectic Die Bond Procedure Application Note
- Vacuum collet is the preferred method of pick-up
- The backside of the die is the source (ground) contact
- Die back side gold plating is 5 microns thick minimum
- Thermosonic ball or wedge bonding are the preferred connection methods
- Gold wire must be used for connections
- Use the die label (XX-YY) for correct orientation

Block Diagram Showing Additional Capacitors & Output Matching Section for Operation Over 2.7 to 3.5 GHz



Designator	Description	Qty
C1, C2, C3, C4, C5, C6, C7, C8	CAP, 120 pF, +/-10%, SINGLE LAYER, 0.035", Er 3300, 100 V, Ni/Au TERMINATION	8
C9, C10, C11, C12	CAP, 680 pF, +/-10%, SINGLE LAYER, 0.070", Er 3300, 100 V, Ni/Au TERMINATION	4

Notes:
¹ The input, output and decoupling capacitors should be attached as close as possible to the die-typical distance is 5 to 10 mils with a maximum of 15 mils.
² The MMIC die and capacitors should be connected with 2 mil gold bond wires.

CMPA2735075D Typical Performance

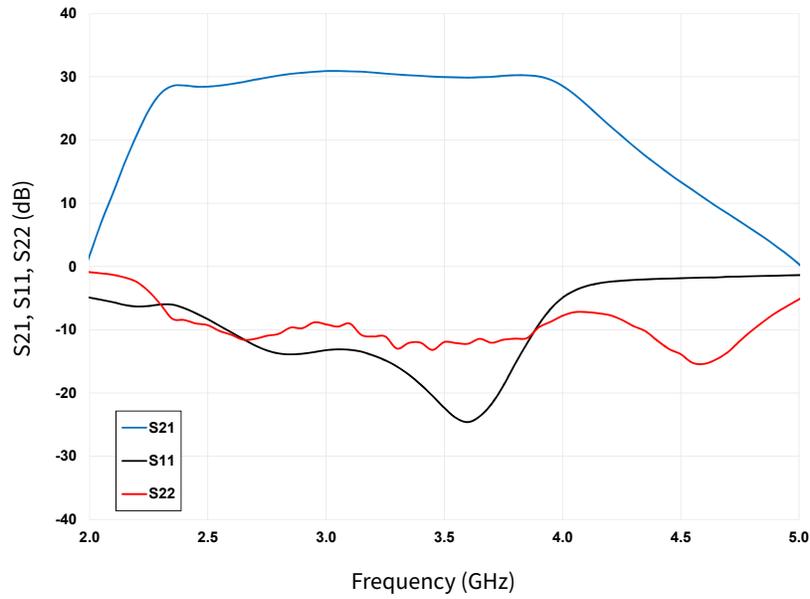


Figure 1. Gain and Input Return Loss vs Frequency
 $V_{DS} = 28\text{ V}, I_{DQ} = 0.8\text{ A}$

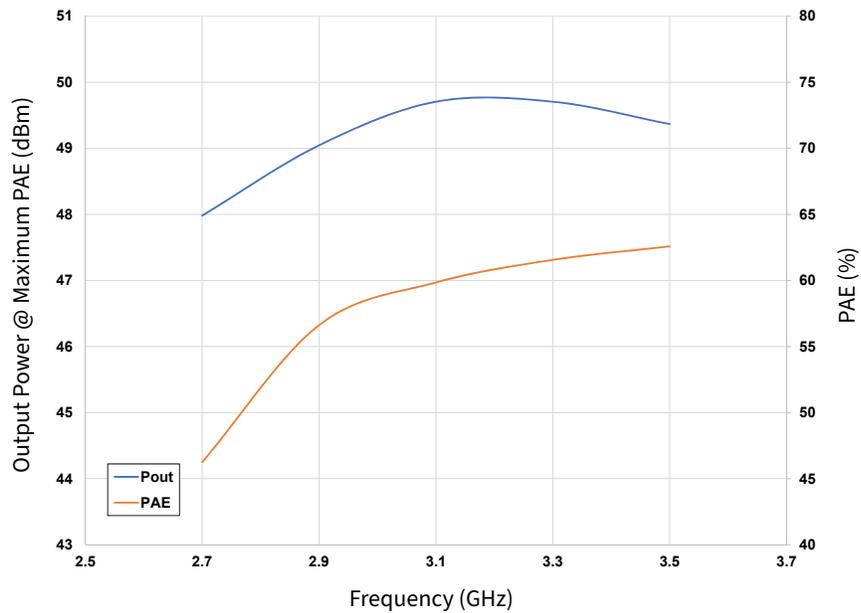


Figure 2. Output Power and Power Added Efficiency vs Frequency
 $V_{DS} = 28\text{ V}, I_{DQ} = 0.8\text{ A}$

CMPA2735075D Typical Performance

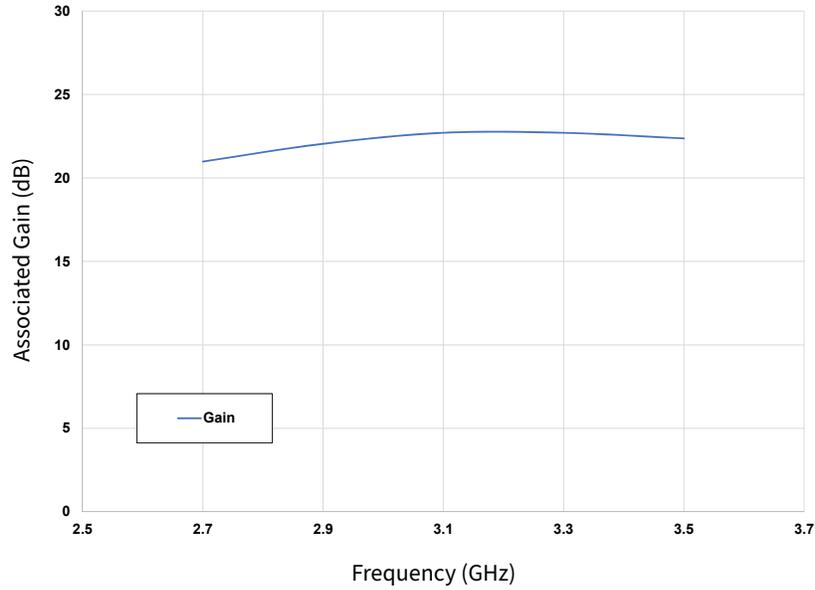


Figure 3. Associated Gain at Maximum Power Added Efficiency vs Frequency
 $V_{DS} = 28\text{ V}$, $I_{DQ} = 0.8\text{ A}$

Part Number System

CMPA2735075D

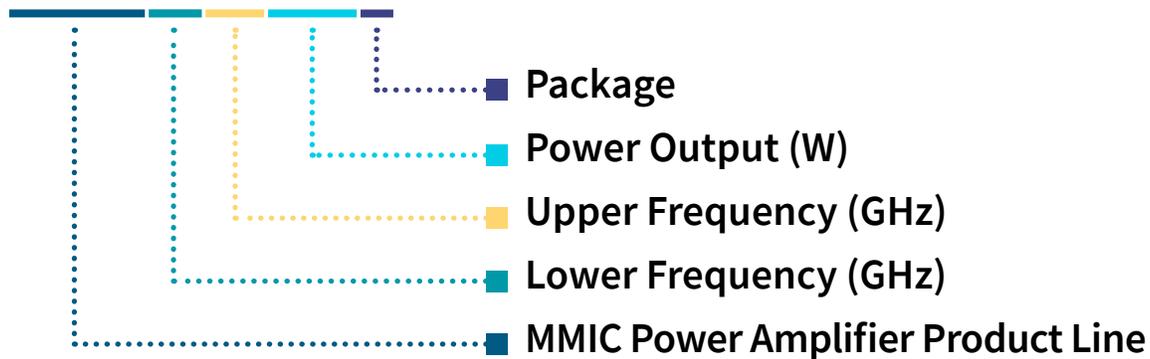


Table 1.

Parameter	Value	Units
Lower Frequency	2.7	GHz
Upper Frequency	3.5	GHz
Power Output	75	W
Package	Bare Die	-

Note:
Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Table 2.

Character Code	Code Value
A	0
B	1
C	2
D	3
E	4
F	5
G	6
H	7
J	8
K	9
Examples:	1 A = 10.0 GHz 2 H = 27.0 GHz

Product Ordering Information

Order Number	Description	Unit of Measure
CMPA2735075D	GaN MMIC Power Amplifier Bare Die	Each

Notes & Disclaimer

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